

<b>Notice of References Cited</b>		Application/Control No. 10/566,730	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
		Examiner MARK EASHOO	Art Unit 1796	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,580,942	12-1996	Cornish, Katrinia	528/1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Cornish et al., Enc. Poly. Sci. and Tech., 2004, (John Wiley and Sons)
	V	
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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